

Notice of References Cited

Application/Control No.

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Applicant(s)/Patent Under
Reexamination
MIURA, MINEO

Examiner

FEI FEI YEUNG LOPEZ

Art Unit

2826

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0119076	06-2004	Ryu, Sei-Hyung	257/077
*	B	US-2004/0159886	08-2004	Lee et al.	257/331
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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